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|---|---|--|---------------------------|
| | Application No. | Applicant(s) | |
| Nation of Allowahility | 10/767,819 | IIJIMA, CHIYOAKI | |
| Notice of Allowability | Examiner | Art Unit | |
| | James A. Dudek | 2871 | |
| The MAILING DATE of this communication appeal claims being allowable, PROSECUTION ON THE MERITS IS herewith (or previously mailed), a Notice of Allowance (PTOL-85) NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT R of the Office or upon petition by the applicant. See 37 CFR 1.313 | (OR REMAINS) CLOSED in this app or other appropriate communication IGHTS. This application is subject to | olication. If not include will be mailed in due | ed course. THIS |
| 1. A This communication is responsive to the application filed 1 | <u>//29/04</u> . | | |
| 2. ☑ The allowed claim(s) is/are <u>1-10</u> . | | | |
| 3. \boxtimes The drawings filed on <u>29 January 2004</u> are accepted by th | e Examiner. | | |
| 4. Acknowledgment is made of a claim for foreign priority una) All b) Some* c) None of the: 1. Certified copies of the priority documents have 2. Certified copies of the priority documents have 3. Copies of the certified copies of the priority do International Bureau (PCT Rule 17.2(a)). * Certified copies not received: | e been received. e been received in Application No. <u>09</u> | | tion from the |
| Applicant has THREE MONTHS FROM THE "MAILING DATE" noted below. Failure to timely comply will result in ABANDONN THIS THREE-MONTH PERIOD IS NOT EXTENDABLE. | | complying with the rec | uirements . |
| 5. A SUBSTITUTE OATH OR DECLARATION must be subm INFORMAL PATENT APPLICATION (PTO-152) which give | | | OTICE OF |
| 6. CORRECTED DRAWINGS (as "replacement sheets") mus | st be submitted. | | |
| (a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached | | | |
| 1) hereto or 2) to Paper No./Mail Date | | | |
| (b) ☐ including changes required by the attached Examiner' Paper No./Mail Date | s Amendment / Comment or in the C | office action of | |
| Identifying indicia such as the application number (see 37 CFR 1 each sheet. Replacement sheet(s) should be labeled as such in t | .84(c)) should be written on the drawin he header according to 37 CFR 1.121(c | igs in the front (not the | back) of |
| DEPOSIT OF and/or INFORMATION about the depo attached Examiner's comment regarding REQUIREMENT | | | Note the . |
| Attachment(s) 1. ☑ Notice of References Cited (PTO-892) 2. ☑ Notice of Draftperson's Patent Drawing Review (PTO-948) 3. ☑ Information Disclosure Statements (PTO-1449 or PTO/SB/0 Paper No./Mail Date | ce of References Cited (PTO-892) 5. Notice of Informal Patent Application (PTO-18) 6. Interview Summary (PTO-413), Paper No./Mail Date 7. Examiner's Amendment/Comment | D-152) | |
| 4. Examiner's Comment Regarding Requirement for Deposit of Biological Material | 8. ⊠ Examiner's Stateme 9. □ Other | nt of Reasons for Allo | wance |

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REASONS FOR ALLOWANCE

The following is an examiner's statement of reasons for allowance: the prior art of record teaches or renders obvious a liquid crystal device comprising: a first transparent substrate; a second transparent substrate opposed to the first substrate; a liquid crystal held between the first and second substrates; a light source provided on a side of the first substrate, which is opposite to the liquid crystal side thereof; a transflective electrode layer arranged on the first substrate opposite to the second substrate; a polarizer provided on a side of the second substrate, which is opposite to a first substrate side thereof; a first retardation plate arranged between the polarizer and the second substrate; and a second retardation plate arranged between the polarizer and the first retardation plate; wherein a twist angle of the liquid crystal is 230 to 260 degrees; a minimum and maximum delta*nd (product of optical anisotropy An and thickness d) of the liquid crystal are 0.85 microns or less and 0.70 microns or more, respectively; delta*nd of the first retardation plate is 150.+-.50 nm or 600.+-.50 m; and delta*nd of the second retardation plate is 550+-50 nm. The prior art of record does not teach nor suggest, in combination with the limitations supra, an angle thetal formed by a transmission axis or absorption axis of the polarizer and an optical axis of the second retardation plate is 15 to 35 degrees; and an angle theta2 formed by an optical axis of the first retardation plate and the optical axis of the second retardation plate is 60 to 80 degrees.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to James A. Dudek whose telephone number is 571-272-2290. The examiner can normally be reached on 9:00-5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robert H. Kim can be reached on 571-272-2293. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866 (217-9) 97 (toll-free).

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